



FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT &amp; TRADEMARK OFFICE

SHEET 1 OF 1  
(REV. 7-80)**LIST OF REFERENCES CITED BY APPLICANT**

(Use Several Sheets if Necessary)

DOCKET NO.:

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APPLICANT:

Takayuki HISANAKA

FILING DATE:

January 16, 2001

CONFIRMATION NO: 5640

**U.S. PATENT DOCUMENTS**

<u>*EXAMINER INITIALS</u>	<u>DOCUMENT NUMBER</u>	<u>DATE</u>	<u>NAME</u>	<u>CLASS</u>	<u>SUBCLASS</u>	<u>FILING DATE</u>
<i>EDW</i>	1. 6,160,200	12/12/00	Ehrnsperger et al.	604	378	6/29/98
<i>EDW</i>	2. 4,959,059	9/25/90	Eilender et al.	604	358	1/17/89
<i>EDW</i>	3. 4,790,836	12/13/88	Brecher	604	359	5/8/86
<i>EDW</i>	4. 4,753,643	6/28/88	Kassai	604	359	2/20/87

**FOREIGN PATENT DOCUMENTS**

<u>*EXAMINER INITIALS</u>	<u>DOCUMENT NUMBER</u>	<u>DATE</u>	<u>COUNTRY</u>	<u>CLASS</u>	<u>SUBCLASS</u>	<u>TRANSLATION YES</u>	<u>NO</u>
<i>EDW</i>	5. WO 98/24390	6/11/98	PCT			X	
<i>EDW</i>	6. WO 98/42286	10/1/98	PCT			X	
<i>EDW</i>	7. WO 99/25287	5/27/99	PCT			X	

**OTHER REFERENCES****(INCLUDING AUTHOR, TITLE DATE, PERTINENT PAGES, ETC.)**

European Search Report

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\*EXAMINER INITIALSEXAMINER: Opusseel/AlW/edwDATE CONSIDERED: 10/22/02

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